Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/767,775	MILLER, KEVIN LEE	
Examiner	Art Unit	
Brian Young	2819	

SEARCHED					
SEARCHED					
Class	Subclass	Date	Examiner		
341	144,143, 155,164, 67,65	8/19/2005	BY		
375	371,372	Ц	BY		
<i>l</i> (373,377	ч	BY		
Įl.	293	U	BY		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST(JPO <epo<derwent) NPL(IEEE<portal)< td=""><td>8/19/2005</td><td>BY</td></portal)<></epo<derwent) 	8/19/2005	BY		